

A Complete Bibliography of Publications in *Technometrics* for the decade 1980–1989

Nelson H. F. Beebe
University of Utah
Department of Mathematics, 110 LCB
155 S 1400 E RM 233
Salt Lake City, UT 84112-0090
USA

Tel: +1 801 581 5254
FAX: +1 801 581 4148

E-mail: beebe@math.utah.edu, beebe@acm.org,
beebe@computer.org (Internet)
WWW URL: <https://www.math.utah.edu/~beebe/>

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Title word cross-reference

#9312 [Hsi80].

(≥ 2) [Sin92]. 2^{k-p} [FH80]. A [HM84]. \bar{X} [RAAN88, San89, BR89, BR88]. β [Mee84a, OCO89]. C_p [Wei81]. D [CN80, DA88, GK80a, Hil80, JN83, Khu84, VDY81, Wel82]. F [LM80, WD81]. K [All84, Gen80, GL84a, GL84b, HLG85, Hoc84, Wei84, Hsi86, Sax81, Sin92]. $k(\geq 2)$ [Sin83]. l [CO86]. Λ [RL80]. M [MRR80, DM87, DM88, Sax81]. $\Pr(Y < X)$ [RG86]. p [DM87, DM88]. p^{n-m} [Fra84, Fra85]. R [San89, DM87, DM88]. R^2 [Agr86a, RP80]. S_B [Mag80]. t [BJ87, Koe83, Wil83]. $|X'X|$ [Bat83].

-Clustering [All84, GL84b, Hoc84, Wei84, GL84a, HLG85]. **-Content** [Mee84a]. **-Control** [BR88, BR89]. **-Estimators** [MRR80]. **-Expectation** [Mee84a, OCO89]. **-Optimal** [CN80, HM84, Hil80, JN83, Khu84, VDY81].

-optimality [Wel82]. **-Optimum** [DA88, GK80a].
 [?]out-of-Saxena:1981:DFT. **-to-Enter** [WD81]. **-Type** [Agr86a].

1 [Har83]. **105D** [JT83]. **12** [Pri81]. **12th** [Fed81j]. **15** [Hsi80]. **17th** [Zie89c].
1964 [Boa85b]. **1979** [Ber83, Fed80c]. **1980** [Fed81d, Fed84d, Par83]. **1981**
 [Aro84a, Han84a]. **1982** [Fed84e].

21 [Kit81]. **22** [FHL81]. **23** [EL83, HL84]. **24** [LM85, Fed82b]. **25** [Sin92]. **28**
 [BM87b, Cro89]. **29** [DM88, Ste90].

3 [Aro84c, Fed81c, Liu89]. **30** [BR89, NP89, WB88a]. **31** [BT98]. **39** [IC89].

4 [Aro84d, Zie88-28].

5 [Aro86a, Sch86b]. **51** [Hsi80].

6 [Aro86b].

79 [Hea82].

80f [Kit81]. **81i** [FHL81]. **82f** [EL83]. **84e** [LM85]. **84f** [HL84]. **84g** [Sin92].
88e [Ste90].

90e [BR89]. **90f** [BT98].

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 [Ber82a, Car87a, NA88, SY87, Per84]. **Accountancy** [Hen86].
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 [J.80e]. **Agostino** [Jac85c]. **Agresti** [McC85]. **Agricultural** [Koc81].
Agriculture [Fed81i]. **AIC** [Kit81, Kit79]. **Aickin** [Gar85]. **Aided**
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[BME85, Boy80, Cha87, LRS82, Lom86, LV86, Rup87, WMS85, Woo84, Yan83, Yfa87, Sin80, Agr89, Cru82, Jac85c, Mac81, She87, St.87, Wat84].

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[BN81, FM80a, GZ79, Koe83, MTL82, Ran82]. **Approach** [Gru88b]. **Araujo**

[Ald81]. **Archetti** [Fed81h]. **Architecture** [Han84b]. **ARIMA** [MHW84].

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[Wu81]. **Associated** [YSOE84]. **Association** [J.80d]. **Assumptions**

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[LD80]. **Azen** [Cru82]. **Azencott** [Gra87a].

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C [Ber89b, Boa85a, Bre89, Cas80, Dal87, Dow88, Fed81b, Gbu81, Gib83, Gos86, Gun85b, Han84a, Has88, Jac81, Jon88, Koc81, Lee83, Mas88, McL89, Mey88, Mil81, Moe83, Nac89, Nac87a, Nyc89, Per89, Pri81, Pro87d, Que88, Roh83b, Sal89, Sar89, Sch81b, Scl81a, Sen80, Shu87, Syl81, Sys82, Tho86, Tho88, Wei87, Zah89, Zie86a, Zie88e, Zie88y]. **Cady** [MM83b]. **Calculating** [Pie83a]. **Calculus** [Zie89j]. **Calibration** [Ano90b, Buo86, CSS88, Eas81, GS82, Hil81, HL81b, HL81a, KSSY84, Law81, LRS82, Lwi81, LM82, MD80, Næs85, Oma84, Orb81, RS81, SS89, SB89, VIC89, HL84, LM85]. **Calibration-Curve** [CSS88]. **Call** [PS87]. **Call-Record** [PS87]. **Calvin** [Car87a]. **Campbell** [Aro83, Bow83]. **Canada** [Fed84d]. **Capability** [GJM89]. **Carbone** [Aro85c]. **Carl** [Hel87, Rao80]. **Carl-Erik** [Rao80]. **Carlo** [Ang88, Sei82, Was89, BM87a, SM84]. **Carlsson** [Han84a]. **Carroll** [Wei90, Ano90c]. **Carson** [Mor84]. **Carter** [Sch84a]. **Carvalho** [Abr81]. **Case** [RG86]. **Casebook** [Klo82]. **Casella** [Zie88y]. **Cases** [CW80, CW83, HW88, Wei81]. **Cassel** [Rao80]. **Castelle** [Gra87a]. **Casti** [Czi89]. **Catalytic** [HMW80]. **Categorical** [Agr86a, Agr86b, Agr88, Bis83, BJ86, BR85, Gok83, McC85, McC86, Nai86a, Nai86b, Tit80b, Wu81]. **Categories** [Jac86a]. **Caulcott** [Zie88i]. **Causal** [Nyc89]. **Cause** [Atw86]. **Celebration** [Zie86a]. **Cell** [Bai80b]. **Cells** [Ano90a, Sim88a]. **Censored** [Ait81, BS83, HMS81, Hsi86, Koz80, Mor88a, Nai84, OS88, San85, SGN85, Sch89b, SH83, Sin83, Sin92]. **Censoring** [Mee84b, Pie87, Rob83, Kim82]. **Censues** [Por82a]. **Center** [Dra82]. **Central** [Ald81]. **Centroids** [Pie83a]. **Chain** [BA89, Car87a, Kat81, Woo84]. **Chalmer** [Pig88]. **Chambers** [Woo86]. **Chance** [Sha82]. **Change** [GM86, Hen86, Lom86, Lom88]. **Change-Point** [Hen86, Lom86]. **Changing** [CB80, VIC89]. **Characteristic** [She81b]. **Characteristics** [Lor80]. **Characterizations** [CW80]. **Charles** [Fed81i, Joh82, Kad84]. **Chart** [BLSF88, San89]. **Charts** [Ano85e, BR88, CW87a, Cro87, LV86, RAN88, Roc89, San89, WLP85, WLV86, BR89]. **Chase** [Gun87]. **Chatfield** [Lee83, Mil81]. **Chatterjee** [Maz89]. **Check** [SKC83]. **Chemical** [Bac80, MW80b, MW80a, TM85, Yfa87, Zai87, Zie89o]. **Chemistry** [Scl81a]. **Chemists** [Zie88e, Zie89m]. **Chemometric** [Agr89]. **Cheremisinoff** [Cro88a, Pro89a]. **Chiang** [McC87]. **Chien** [Sin82]. **Chien-Pai** [Sin82]. **Chin** [Maz88, McC87]. **Chin-Kuei** [Maz88]. **Cho** [Maz88]. **Choice** [EK82, GZ79]. **Cholesky** [HE82]. **Chomet** [Roh83a]. **Chosen** [CR80]. **Chris** [Boy80]. **Christensen** [Bor87, Smi87]. **Chronological** [Sch85g]. **Circuit** [Mee87b]. **Circular** [Wat82]. **Civil** [Lee89b]. **Claes** [Rao80]. **Claes-Magnus** [Rao80]. **Claire** [Jon89b]. **Clark** [Sch89d, Edd87, Jac85b, Zie88c]. **Clarke** [Sto80]. **Class**

[LLS80, NA88, Par87]. **Classical** [Bru86, Hur86, Cor87]. **Classification** [BG84, CW87b, Fed84b, JG80, Lin81a, SK84, SK85, Gra87b, Lac82]. **Classifications** [J.80d]. **Classified** [J.80a, Jac86a]. **Classifiers** [GS82]. **Cleveland** [Col87, Zie89v]. **Clinical** [Ker85]. **Cluster** [Lin81b, Zem86, Lac81, Lin81a]. **Clustering** [All84, GL84a, GL84b, HLG85, Hoc84, Wei84, Lan87]. **Clyde** [Asc89]. **Cochran** [Cor81, Sav83]. **Code** [Mul83]. **Coefficient** [New80, dVS89]. **Cohen** [Mar83, Mul89]. **Coles** [Syl81]. **Colin** [Zie89d]. **Collected** [Boa85b, Boa85a, Zie88-27, Zie88-28, Zie89v]. **Collection** [Han84a, Sch87a, Zie87a]. **Collinearities** [MG85]. **Collinearity** [Par81]. **Collins** [Lee83]. **Colloquia** [Fed82b]. **Colombo** [Lee89c]. **Combinations** [BG84]. **Combinatorial** [Ber89a, Fed81a]. **Combined** [Ham85, Miy82]. **Combining** [HR88]. **Comment** [Atk84, Bec84, Cop83, Cor84, Cox84, Hah84b, Joi84, Pik84, SH84a, SH84b, Zie84]. **Common** [Atw86, SB83, SS81, YSOE84]. **Compact** [Cas80]. **Comparative** [Ano84e, CJJ81, Mee82, Nai84, Tit80b, Har86]. **Compare** [SC82]. **Comparing** [BT81, BT83, Hsi86, Lee80a, Tor89]. **Comparison** [Atk81, Bjø80, Bru86, Cam83, CN80, DG87, Khu86, Lit89, Mee84b, SM84, WTA80]. **Comparisons** [BD82a, HM84, Chr89]. **Competing** [Eas80b]. **Complete** [BS83, MTL82]. **Complex** [Hah84a]. **Component** [EK82, Goo88, HGB89, Maz80, Miy82, Pie82]. **Components** [Bre89, BG84, Cha87, EK82, Fel86, GC82, HJ86, JG80, MWF88, Swa81b, SM84, Sax81]. **Composite** [Dra85, ETM80, Rub80]. **Compositional** [Pie88a]. **Compound** [LM82, MLG82, LM85]. **Comprehensive** [Zie89u]. **Compstat** [Zie88n]. **Computation** [MG84, Ste89a]. **Computational** [DS87, Sch82, Zie88n]. **Computer** [CN89, Cru82, Der89, Fed81j, GK80a, Hau89, Hea82, Hod89, J.80e, Luc81, Mul83, SSW89, Wel84, Zie88v, Zie89x, DeP88a, Fed82a, Jac85b, Zie89c]. **Computer-Aided** [CN89, Wel84, Jac85b]. **Computers** [Cas80, Han84b, Zie89q]. **Computing** [Edd87, Ell82, Har89a, Kao88, Ste89a, Rel82, Zie87d, Gun85a]. **Concentration** [SMV82]. **Concentrations** [SAJ89, Ven82]. **Concepts** [Ber82c, Gro89, Hau89, Pro87a, Pro88a]. **Conceptual** [She87]. **Conditioning** [BH84]. **Conference** [Aro84a, Fed80c, Fed81d, Fed81k, Fed84e, Par83, Zie89n, Fed81i]. **Confidence** [Bai80b, BE81, BA89, BG84, CCMC86, CI83, Che87, CI88, Cro82, Dal83, DS87, DL87, GJBR88, JT83, JG80, MD80, McD81, Nai84, Pie86, Rob83, San85, Sch84c, SGN85, Sch87b, ST86, Spu81]. **Conflict** [DeG81]. **Confounded** [Fra85]. **Confounding** [Col89]. **Conolly** [Che83]. **Conover** [Obr81]. **Consequences** [MK84]. **Considerations** [Buo86]. **Consistent** [Pie83b]. **Consonance** [Sal80]. **Constance** [Aro84b]. **Constant** [Hjo80]. **Constantin** [Har89a]. **Constituents** [SMV82]. **Constrained** [Cro86a, Pie82, Pie83a]. **Constraint** [Pie83b]. **Constructing** [CN80, FMM80, Fra84, JN83, PG86]. **Construction**

[DA88, Hai87a, NG85, Wu81]. **Consultant** [Zie89w]. **Consulting** [Gun84]. **Contagious** [Kat82]. **Contemporaneously** [DP81]. **Contemporary** [Sch88]. **Content** [Mee84a]. **Continental** [Ano84e, CJJ81]. **Contingency** [Ano90a, Odo80, Sim88a]. **Continuous** [Car87a, CLS86, CI83, Haw80, She81a, Sys82, Woo83, Yan83]. **Contrasts** [BD82a, Fra85]. **Contributions** [Sav83]. **Control** [AW89, Ano85e, Bac80, BR88, BH80, BT81, BT83, BLSF88, Ber87, Bry89, CW87a, Cro86b, Cro88b, DPM80, Fed81b, Gun83, HMW80, HM84, Hsi87, Koc81, Liu89, Loc87, LV86, LC82, MW80b, MW80a, MHW84, Pie90, Roc89, San89, Syl87, Vin89, Wal86, WLP85, WN85, WLV86, Zie88x, BR89, Cro89, Fed84a, Maz88, Per82, Per84, Per88, Pro87d, Que88, Sta88, Tuc84, Voe89, Woo86, Zie88f]. **Control-Chart** [San89]. **Control-Test** [HM84]. **Controllers** [HMW80]. **Controversies** [Pro87a]. **Controversy** [LM82, LM85]. **Convergence** [BW81]. **Convex** [JN83]. **Cook** [Lin84]. **Cooke** [Edd87, Sto80]. **Cooley** [Zie88k]. **Coomans** [Zai87]. **Coombs** [Asc89]. **Coordinate** [Han89]. **Coordinate-Free** [Han89]. **Cornell** [Dic82, Pro87c, St.89, Zie87h]. **Cornwell** [Spr83]. **Corrected** [Gan81]. **Correction** [Ano86e, Ano90a, Ano90b, BR89, BT98, BM87b, Cro89, IC89, LM85, McL80, NP89, Sin92, Ste90, YB87]. **Corrections** [Ano85e, Ano90c, DM88, WB88a]. **Correlated** [DP81, Hen86, Khu86, OL81, Tan87, WMS85]. **Correlation** [EJG84, HE82, IC87, IC89, Tuc82]. **Corrigenda** [Ano80e, Ano80f, Ano81e, Ano82e, Ano82f, FHL81, Kit81]. **Corrigendum** [Ano80g, Ano83e, Ano84e, Ano84f, EL83, HL84]. **Cost** [Gau88]. **Counted** [Luc85]. **Counterexamples** [EL81, EL83, Zie88o]. **Counting** [Nel83, Far88a]. **Course** [Far88b, Goo87, MM82b, Roh83a, Sto80, Zie88k, Hix87]. **Covariance** [HE82, Low83b, Næs85, War87b]. **covariates** [Wu81]. **Cox** [Boe83, BJ81, Col88a, Has88]. **Coxon** [Jac85f, Jac85d]. **Craven** [Edd87]. **Credal** [Sha82]. **Crew** [Fed82a]. **Critchlow** [Sin87]. **Criteria** [Atk81, Box88a, Box88b, CR88, Gun88b, Han84a, Kat81, NP88a, Par88b, STL88, Ull88, Wel82]. **Criterion** [BW81, Bro89, HH81, HW85, NW79, You82]. **Criticisms** [EL81, EL83]. **Crocker** [Pro87d]. **Crop** [Chh86]. **Cross** [EK82, J.80d, Jac86a, JG80]. **Cross-Classification** [JG80]. **Cross-Classified** [Jac86a]. **Cross-Validatory** [EK82]. **Crossings** [Ked87]. **Crow** [Job89]. **Cryer** [Bow87]. **Csőrgö** [Fed84d]. **CSP** [Car87a, She81a]. **Cubic** [Dra83a]. **Cugiani** [Fed81h]. **Cumulative** [CI83, CI88, Cro86b, Cro88b, HH81, Yas89, Cro89]. **Cureton** [Jac85c]. **Current** [BE80]. **Curtailed** [Ano85e, WLP85]. **Curve** [CSS88, DV86, MD80, She81b]. **Curves** [CLS86, Nel85, VIC89]. **CUSUM** [Hea87, LC82, Luc85, VoR85, Wal86, Woo83, Woo84, WN85]. **Cut** [DV85]. **Cuthbert** [Luc81]. **Cyclic** [Mor88b].

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Har86, Har87, Hei80b, Hsi80, J.80b, J.80c, Jac80c, Jac85c, Kim82, Kle82, Lac82, Lee89a, Mee87a, Mee86, Nel81, Odo80, Par83, Roh83a, Sch81b, Sch84c, Sch87a, Sin80, Sin81, Sto80, Ter89, Wal89, Web83, Wei90, Woo86, Zai80, Zai87, Zie87e, Zie87a, Zie89p, Zie89e, Zie89a, Zie89w]. **Dacunha** [Gra87a]. **Dacunha-Castelle** [Gra87a]. **Dagnelie** [Pil83b, Pil83a]. **D'Agostino** [Kin87]. **Dallas** [Sch85a]. **Dan** [Fed81i, Har89a]. **Daniel** [Agr88, Ell82, Kad84, Koc81, Luc81, She81b, Win87, Hei80b, Pen81, Zie88m]. **Data** [Agr86a, Agr86b, Agr88, Ait81, Ano84e, BJ87, Ber84, Ber89a, BJ86, BR85, Chh86, CJJ81, CJ86, Cre87, Deh87a, Fed81k, GM86, Gok83, GC85, Gri89, GH80, HMS81, Hai87b, HBK84, Hoe87, Hsi86, Hur86, Jac80d, Jac85e, Jac85a, Jac86a, Kad84, Koz80, Lak87, Lan87, Lee80c, Len81b, Lin81a, Lom86, Luc81, Luc85, Mac81, McC86, MM83b, Mea89, Miy82, Moe83, Mor87, Nai84, Nai86a, Nai86b, Par88c, Pro87b, Pry89, Rab89, Rig89, San85, Sch85a, Sch89c, SH83, She89, SW86, Shu87, SAJ89, Sid82, Sin81, SG80, SS81, Suz85, TM85, Tho86, Tit80b, Tup89, ZG80, Zie88k, Zie88-27, Zie89d, Zie89r, Zie89l, Zie89x, dLNB⁺81, Bin89, Bis83, Col87, Cre87, Dic82, Gar85, Gho88, Hac80, Hin87, Ing81, Iye87, Jac81, Kan87b, Kle82, Kot88, Lac82, Luc81]. **Data** [McC85, Pie88a, Ree88, Roc87a, Sch83b, Sch86c, Sin87, Ste89b, Tur89, You80, Zie89s, Bor87, Sch87a, Zie87a]. **Data-Dependent** [Hur86]. **Data-Oriented** [Mac81]. **Davenport** [Hea89, Khu87]. **David** [Boa85b, Dow88, Jac89, MM83b, Pro87a, Pro88a, Sch84g, Sch87b, Sid84, St.87, Tho86, Wat84, Zie89c, Chr89, Mac83]. **Davies** [Jac85d]. **Davis** [Ano80e, Dic89, Shu87, Tuc84]. **Dawson** [Fed84d]. **Dean** [Bea83, Dun89, Fed81]. **DeAntoni** [Zie88n]. **Decade** [Lam84b]. **Decision** [Ber82c, Cal88, Dud82, Han84a, Han85b, Zai87]. **Decisions** [Har87]. **Deconvolution** [SD85]. **Decreasing** [DV86, FG88, Hjo80]. **deFinetti** [Swa81a]. **Defining** [Fra85, Pie83b]. **DeGroot** [Ber83, Zie87f]. **Dehnad** [Pie90]. **DeMaio** [Low82]. **Deming** [Agr89]. **Dennis** [Gri88, Lam84c, Lin84, Mee87a, Pro88a]. **Density** [DV86, Tit80b, Deh87a]. **Departures** [MK84]. **Dependent** [Hur86, SC82]. **Depends** [PC85]. **DePriest** [Sch84e, Mie82, Thi88]. **Derivative** [Bat83]. **Dertougos** [J.80e]. **Design** [Agr89, Ano85e, Atk81, Atk84, BR88, BT83, Bec84, Bis89, Buo86, Che87, Cor84, Cox84, Dea82, FTK89, Gup89, Hah84a, Hah84b, HW85, Han86, JN83, Joi84, Lee89b, LV86, Mor87, Pie90, Pik84, Sen89, SH84a, SH84b, Tan87, Tit80a, Wel84, WLP85, WLV86, Zem86, Zie84, Zie88y, BR89, Law86c, Nac87a, Caf87, Gun85b, Mey88, Zie89d]. **Designed** [Sch85a]. **Designing** [Par89]. **Designs** [AD83, BT81, BD82b, BM86b, CN80, CN82, CN89, Dic82, DA88, Dra82, Dra83a, Dra85, DS88, DJ88, Fed81a, Fra84, FH80, GK80a, GJM89, Hai87a, HM84, Hil80, JN83, Khu84, Khu88, MM83c, NGG83, Par87, SSW89, San89, SM81, SS82, St.89, VDY81, Zie88e, BM87b, Wel82, Dea81, Ens80, Mor88b, Nac87b, Pro89c, Zie85a, Zie87b]. **Destructive** [EJG84, SY87]. **Detect** [Sim88b]. **Detecting** [Ano90a, Boo87, CW80, CP81, Lom88, Mar85, MM83c, Sim88a, Wan87]. **Detection** [AC89, All84, Dav79, GL84a, GL84b, HLG85, Hoc84, Jai81, Kit79,

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Sch85g, Sch85c, Sen89, She81a, Spr83, Zie88-27, Zie89h, Zie89v]. **Vols** [Ano86e]. **Volume** [Ano80p, Ano81m, Ano82o, Ano83m, Ano84n, Ano85l, Ano86j, Ano87i, Ano88i, Ano89i, Boa85b, Cre87, Fed81c, Fed81e, Fed84b, Har83, LRS82, Lin81b, Ran87, Sch85a, Sch86b, Was89, Zie87c, Zie87b, Car87a, Car87a, Col88b, Col88a, Kan87b, Kan87a, Pro87b, Pro87c, Pro87d, Zie87h]. **Volumes** [Zie88-28].

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